# **BUK7107-40ATC**

# N-channel TrenchPLUS standard level FET

Rev. 02 — 6 February 2009

**Product data sheet** 

### 1. Product profile

#### 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include TrenchPLUS diodes for clamping and temperature sensing. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

#### 1.2 Features and benefits

- Allows responsive temperature monitoring due to integrated temperature sensor
- Low conduction losses due to low on-state resistance
- Q101 compliant

#### 1.3 Applications

- Electrical Power Assisted Steering (EPAS)
- Variable Valve Timing for engines

#### 1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C};$	[1]	-	-	40	V
$I_D$	drain current	$V_{GS}$ = 10 V; $T_{mb}$ = 25 °C; see <u>Figure 2</u> ; see <u>Figure 3</u> ;	[2]	-	-	75	Α
Static cha	racteristics						
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure 7}}{\text{Figure 8}};$ see Figure 8		-	5.8	7	mΩ
S <sub>F(TSD)</sub>	temperature sense diode temperature coefficient	$I_F = 250 \mu A; T_j > -55 °C;$ $T_j < 175 °C$		-1.4	-1.54	-1.68	mV/K
V <sub>F(TSD)</sub>	temperature sense diode forward voltage	$I_F = 250 \mu A; T_j = 25 °C$		648	658	668	mV
V <sub>F(TSD)hys</sub>	temperature sense diode forward voltage hysteresis	$I_F < 250 \mu A; T_j = 25 °C;$ $I_F > 125 \mu A$		25	32	50	mV

<sup>[1]</sup> Voltage is limited by clamping.



<sup>[2]</sup> Continuous current is limited by package.

# 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		d a
2	Α	anode	mb	
3	D	drain		
4	K	cathode		9 ( → → → )
5	S	source	(1113(11)	
mb	D	mounting base; connected to drain	∐∐ ∐∐ 1 2 4 5	MBL306 S K
			SOT426 (D2PAK)	

# 3. Ordering information

Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
BUK7107-40ATC	D2PAK	plastic single-ended surface-mounted package (D2PAK); 5 leads (one lead cropped)	SOT426			

## 4. Limiting values

Table 4. Limiting values

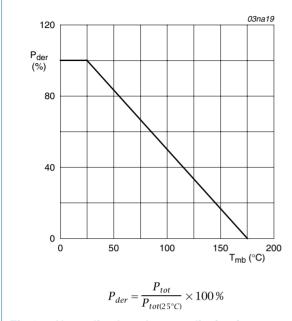
In accordance with the Absolute Maximum Rating System (IEC 60134).

		,				
Symbol	Parameter	Conditions		Min	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C;	[1]	-	40	V
$V_{DGS}$	drain-gate voltage	$I_{DG} = 250 \mu A$		-	40	V
$V_{GS}$	gate-source voltage			-20	20	V
I <sub>D</sub>	drain current	$T_{mb} = 25  ^{\circ}\text{C};  V_{GS} = 10  \text{V};  \text{see } \frac{\text{Figure 2}}{\text{Figure 2}};$	[2]	-	140	Α
		see Figure 3;	[3]	-	75	Α
		T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 10 V; see <u>Figure 2</u>	[3]	-	75	Α
$I_{DM}$	peak drain current	$T_{mb}$ = 25 °C; $t_p \le 10 \mu s$ ; pulsed; see Figure 3		-	560	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 1</u>		-	272	W
I <sub>DG(CL)</sub>	drain-gate clamping current	pulsed; $t_p = 5$ ms; $\delta = 0.01$		-	50	mA
I <sub>GS(CL)</sub>	gate-source clamping	continuous		-	10	mA
	current	pulsed; $t_p = 5$ ms; $\delta = 0.01$		-	50	mA
$V_{isol(FET-TSD)}$	FET to temperature sense diode isolation voltage			-100	100	V
T <sub>stg</sub>	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-drai	n diode					
Is	source current	$T_{mb} = 25  ^{\circ}C;$	[2]	-	140	Α
		T <sub>mb</sub> = 25 °C;	[3]	-	75	Α
I <sub>SM</sub>	peak source current	$t_p \le 10 \mu\text{s}; \text{ pulsed};  T_{\text{mb}} = 25 ^{\circ}\text{C}$		-	560	Α
Clamping						
E <sub>DS(CL)S</sub>	non-repetitive drain-source clamping energy	$I_D = 75 \text{ A; V}_{DS} \leq 40 \text{ V; V}_{GS} = 10 \text{ V; R}_{GS} = 10 \text{ k}\Omega;$ unclamped; $T_{j(init)} = 25 \text{ °C}$		-	1.4	J
Electrostation	Discharge					
V <sub>esd</sub>	electrostatic discharge voltage	HBM; C = 100 pF; R = 1.5 kΩ		-	6	kV

<sup>[1]</sup> Voltage is limited by clamping.

<sup>[2]</sup> Current is limited by power dissipation chip rating.

<sup>[3]</sup> Continuous current is limited by package.



Normalized total power dissipation as a function of mounting base temperature

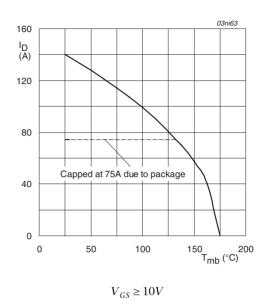
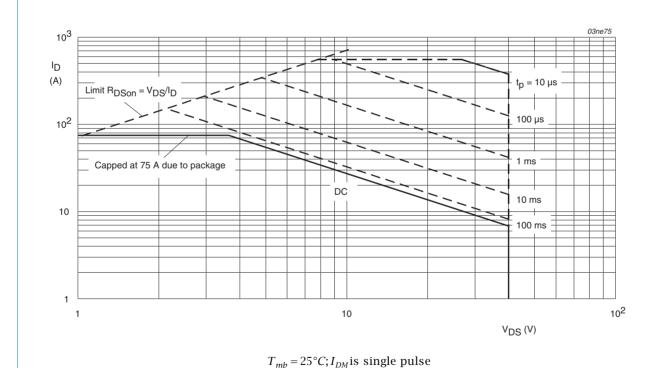


Fig 2. Normalized continuous drain current as a function of mounting base temperature



### 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	minimum footprint; mounted on a printed-circuit board	-	50	-	K/W
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	see Figure 4	-	-	0.55	K/W

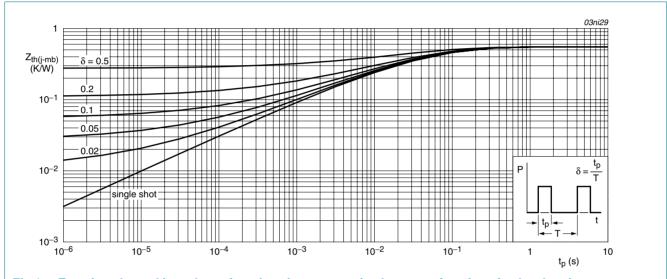


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

### 6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{(BR)DG}$	drain-gate (Zener	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	40	-	-	V
	diode) breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	40	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see Figure 9	2	3	4	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 175$ °C; see Figure 9	1	-	-	V
		$I_D = 1 \text{ mA}$ ; $V_{DS} = V_{GS}$ ; $T_j = -55 \text{ °C}$ ; see Figure 9	-	-	4.4	V V V V V μΑ μΑ V V nA nA μΑ μΑ mΩ
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.1	10	μΑ
		V <sub>DS</sub> = 40 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 175 °C	-	-	250	μΑ
V <sub>(BR)GSS</sub> gate-source break voltage	gate-source breakdown voltage	$I_G = 1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j > -55 \text{ °C};$ $T_j < 175 \text{ °C}$	20	22	-	V
		$I_G = -1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j > -55 \text{ °C};$ $T_j < 175 \text{ °C}$	20	22	-	V
I <sub>GSS</sub>	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C}$	-	5	1000	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 25 \text{ °C}$	-	5	1000	nA
		V <sub>DS</sub> = 0 V; V <sub>GS</sub> = 10 V; T <sub>j</sub> = 175 °C	-	-	10	μA
		V <sub>DS</sub> = 0 V; V <sub>GS</sub> = -10 V; T <sub>j</sub> = 175 °C	-	-	10	
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A}; T_j = 25 \text{ °C};$ see Figure 7; see Figure 8	-	5.8	7	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see Figure 7; see Figure 8	-	-	14	mΩ
$V_{F(TSD)}$	temperature sense diode forward voltage	$I_F = 250 \mu A; T_j = 25 \text{ °C}$	648	658	668	mV
S <sub>F(TSD)</sub>	temperature sense diode temperature coefficient	$I_F = 250 \mu A; T_j > -55 \text{ °C}; T_j < 175 \text{ °C}$	-1.4	-1.54	-1.68	mV/K
$V_{F(TSD)hys}$	temperature sense diode forward voltage hysteresis	$I_F < 250 \mu A; I_F > 125 \mu A; T_j = 25 °C$	25	32	50	mV
Dynamic o	haracteristics					
Q <sub>G(tot)</sub>	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 32 \text{ V}; V_{GS} = 10 \text{ V};$	-	108	-	nC
Q <sub>GS</sub>	gate-source charge	T <sub>j</sub> = 25 °C; see <u>Figure 14</u>	-	21	-	nC
$Q_{GD}$	gate-drain charge		-	42	-	nC
C <sub>iss</sub>	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	4500	-	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; see <u>Figure 12</u>	-	960	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	510	-	pF

Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
t <sub>d(on)</sub>	turn-on delay time	$V_{DS}$ = 30 V; $R_L$ = 1.2 $\Omega$ ; $V_{GS}$ = 10 V;	-	2	-	μs
t <sub>r</sub>	rise time	$R_{G(ext)} = 1 \text{ k}\Omega; T_j = 25 \text{ °C}$	-	5.7	-	μs
t <sub>d(off)</sub>	turn-off delay time		-	8.9	-	μs
t <sub>f</sub>	fall time		-	6.8	-	μs
L <sub>D</sub>	internal drain inductance	from upper edge of drain mounting base to centre of die; $T_j = 25  ^{\circ}\text{C}$	-	2.5	-	nΗ
L <sub>S</sub>	internal source inductance	from source lead to source bond pad; $T_j = 25  ^{\circ}\text{C}$	-	7.5	-	nΗ
Source-dr	ain diode					
$V_{SD}$	source-drain voltage	$I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 19</u>	-	0.85	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = -10 \text{ V};$	-	80	-	ns
$Q_r$	recovered charge	$V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$	-	200	-	nC

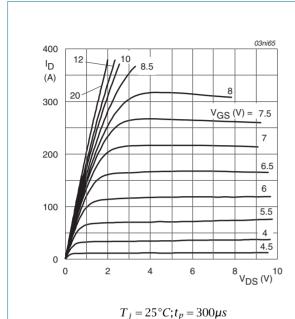
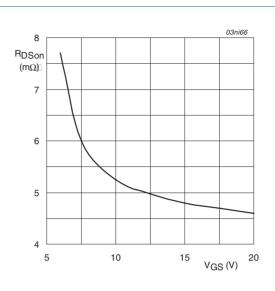


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_{j} = 25\,^{\circ}C; I_{D} = 50A$  Drain-source on-state resistance as a function

of gate-source voltage; typical values

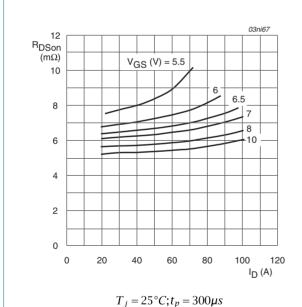


Fig 7. Drain-source on-state resistance as a function of drain current; typical values

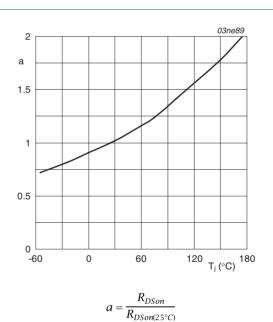
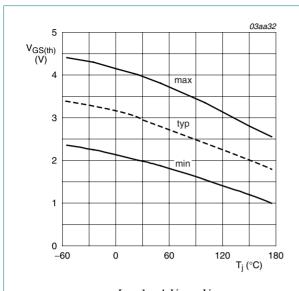


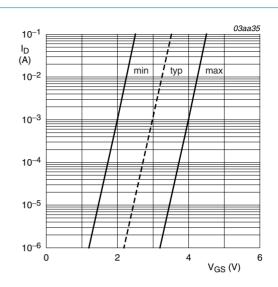
Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature

Fig 6.



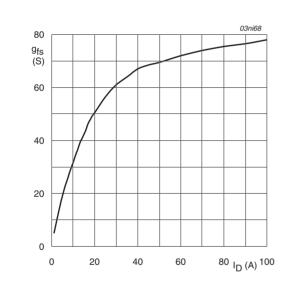
 $I_D = 1\,mA; V_{DS} = V_{GS}$ 

Fig 9. Gate-source threshold voltage as a function of junction temperature



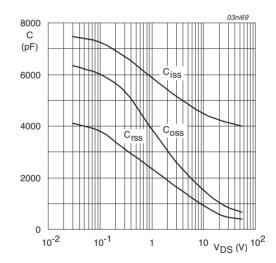
$$T_{j} = 25 \,^{\circ}C; V_{DS} = 5V$$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



 $T_j = 25$ °C; $V_{DS} = 25V$ 

Fig 11. Forward transconductance as a function of drain current; typical values



$$V_{GS} = 0V; f = 1MHz$$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

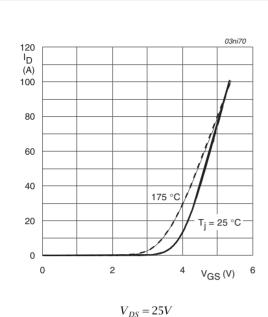
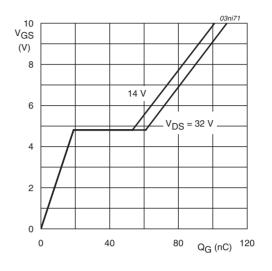
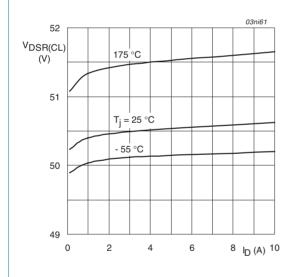


Fig 13. Transfer characteristics: drain current as a function of gate-source voltage; typical values

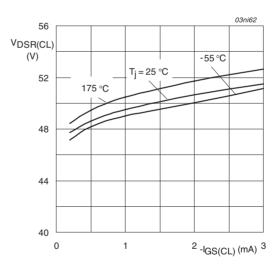


$$T_i = 25^{\circ}C; I_D = 25A$$

Fig 14. Gate-source voltage as a function of turn-on gate charge; typical values



 $I_{GS(CL)} = -2mA$  Fig 15. Drain-source clamping voltage as a function of drain current; typical values



 $I_D = 10A$ 

Fig 16. Drain-source clamping voltage as a function of gate-source current; typical values

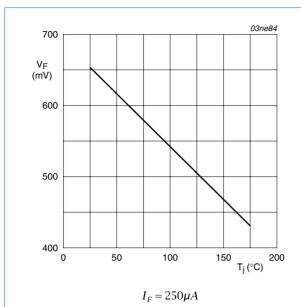
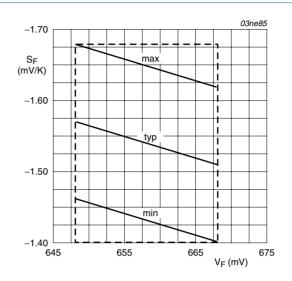


Fig 17. Forward voltage of temperature sense diode as a function of junction temperature; typical values



 $V_F$  at  $T_j = 25^{\circ}C$ ;  $I_F = 250 \mu A$ 

Fig 18. Temperature coefficient of temperature sense diode as a function of forward voltage; typical values

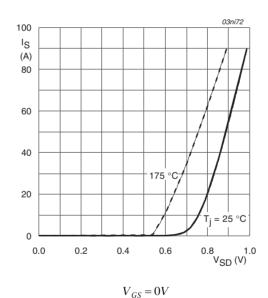


Fig 19. Reverse diode current as a function of reverse diode voltage; typical values

## 7. Package outline

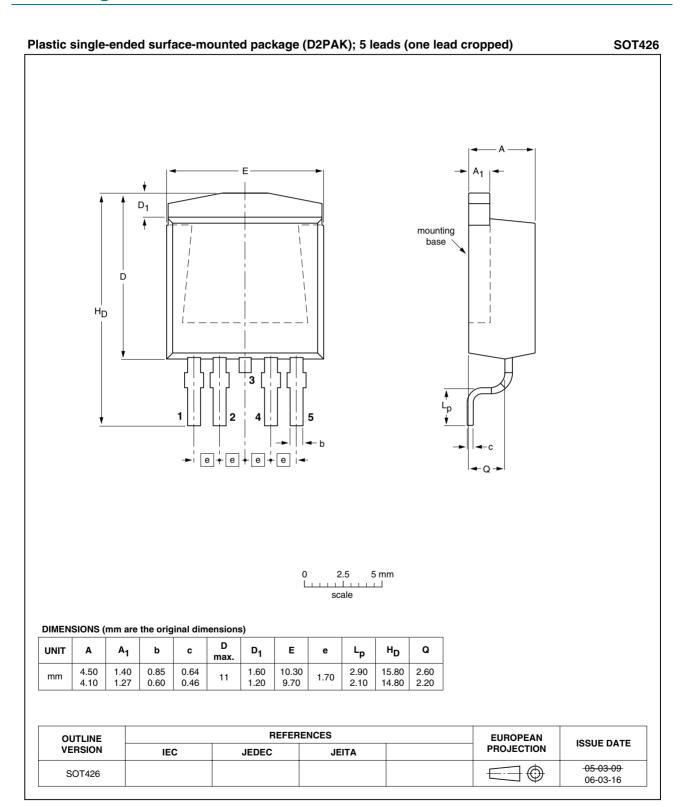


Fig 20. Package outline SOT426 (D2PAK)

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#### N-channel TrenchPLUS standard level FET

# 8. Revision history

#### Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
BUK7107-40ATC_2	20090206	Product data sheet	-	BUK71_7907_40ATC-01		
Modifications:	<ul> <li>The format guidelines</li> </ul>	ith the new identity				
	<ul> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>					
	<ul> <li>Type numb</li> </ul>	er BUK7107-40ATC separ	ated from data sheet BUK	(71_7907_40ATC-01.		
BUK71_7907_40ATC-01 (9397 750 09874)	20020809	Product data sheet	-	-		

### 9. Legal information

#### 9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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For sales office addresses, please send an email to: salesaddresses@nxp.com

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